

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination RADHAKRISHNAN ET AL.	
		10/620,814 <i>EDNA WONG</i>	Examiner Edna Wong	Art Unit 1753

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,559,112	12-1985	Tamamura et al.	205/50
	B	US-5,126,017	06-1992	Nakama et al.	205/159
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 02018423 A	01-1990	Japan	TOYOSAWA et al.	C08G 85/00
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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